

Notice of References Cited

Application/Control No.
10/024,172

Applicant(s)/Patent Under
Reexamination
GOLE ET AL.

Examiner
Maureen M. Wallenhorst

Art Unit
1743

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	X	Sastray et al. Langmuir, vol. 16, February 23, 2000, pages 3553-3556.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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